Application/Control No. Reexamination 10/538,680 CHAPMAN ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 1709 Robert Loewe

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	. Name	Classification
*	Α	US-4,245,079 ⁻ A	01-1981	Matsumoto et al.	528/15
*	В	US-5,536,803 A	07-1996	Fujiki et al.	528/15
*	С	US-6,127,502 A	10-2000	Krahnke et al.	528/10
*	D	US-2002/0099114 A1	07-2002	Nakayoshi et al.	523/209
*	E	US-2006/0111491 A1	05-2006	Asch et al.	524/261
	F	US-			
	G	US-			
	H	US-			
	_	US-			
	J	US-			
	,K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Ρ					
	a		C-			
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

HON-FAILNI DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	כ						
	٧						
	>						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under